

STARPOWER

SEMICONDUCTOR

MOSFET

MD400CUR120C2S

1200V/400A chopper in one-package

General Description

STARPOWER MOSFET Power Module provides very low $R_{DS(on)}$ as well as optimized intrinsic diode. It's designed for the applications such SMPS and DC drives.

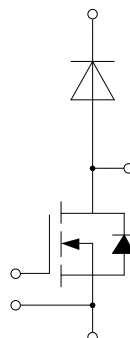
Features

- SiC power MOSFET
- Low $R_{DS(on)}$
- Optimized intrinsic reverse diode
- Chip sintering technology
- Low inductance case avoid oscillations
- Isolated copper baseplate using AlN DBC technology

Typical Applications

- Main and auxiliary AC drives of electric vehicles
- DC servo and robot drives
- Battery vehicles
- UPS equipment
- Plasma cutting

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_C=25^{\circ}\text{C}$ unless otherwise noted**MOSFET**

Symbol	Description	Value	Unit
V_{DSS}	Drain-Source Voltage	1200	V
V_{GSS}	Gate-Source Voltage	± 20	V
I_D	Drain Current @ $T_C=25^{\circ}\text{C}$	542	A
	@ $T_C=90^{\circ}\text{C}$	400	A
I_{DM}	Pulsed Drain Current	1644	A

Inverse Diode

Symbol	Description	Value	Unit
I_S	Source Current	400	A
I_{SM}	Pulsed Source Current	1644	A

Series Diode

Symbol	Description	Values	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1200	V
I_F	Diode Continuous Forward Current	400	A
I_{FM}	Diode Maximum Forward Current $t_p=1\text{ms}$	800	A

Module

Symbol	Description	Value	Unit
T_{jmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{jop}	Operating Junction Temperature	-40 to +150	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}$, $t=1\text{min}$	2500	V

MOSFET Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit	
$R_{DS(on)}$	Static Drain-Source On-Resistance	$I_D=240\text{A}, V_{GS}=18\text{V}, T_j=25^\circ\text{C}$		3.3	4.4	$\text{m}\Omega$	
		$I_D=240\text{A}, V_{GS}=18\text{V}, T_j=125^\circ\text{C}$		5.0			
$V_{GS(th)}$	Gate-Source Threshold Voltage	$I_D=120\text{mA}, V_{DS}=V_{GS}, T_j=25^\circ\text{C}$	2.7		5.6	V	
g_{fs}	Forward Transconductance	$V_{DS}=10\text{V}, I_D=240\text{A}$		99.6		S	
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=V_{DSS}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$			120	μA	
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=V_{GSS}, V_{DS}=0\text{V}, T_j=25^\circ\text{C}$			1.2	μA	
R_{Gint}	Internal Gate Resistance			0.75		Ω	
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=800\text{V}, f=1\text{MHz}$		16.0		nF	
C_{oss}	Output Capacitance			0.90		nF	
C_{rss}	Reverse Transfer Capacitance			0.33		nF	
Q_g	Total Gate Charge	$I_D=240\text{A}, V_{DS}=600\text{V}, V_{GS}=18\text{V}$		1284		nC	
Q_{gs}	Gate-Source Charge			264		nC	
Q_{gd}	Gate-Drain ("Miller") Charge			492		nC	
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=900\text{V}, I_D=400\text{A}, R_G=1.6\Omega, V_{GS}=0/+18\text{V}, T_j=25^\circ\text{C}$		93		ns	
t_r	Rise Time			93		ns	
$t_{d(off)}$	Turn-Off Delay Time			296		ns	
t_f	Fall Time			78		ns	
E_{on}	Turn-On Switching Loss				8.47		mJ
E_{off}	Turn-Off Switching Loss				31.5		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=900\text{V}, I_D=400\text{A}, R_G=1.6\Omega, V_{GS}=0/+18\text{V}, T_j=125^\circ\text{C}$		95		ns	
t_r	Rise Time			95		ns	
$t_{d(off)}$	Turn-Off Delay Time			336		ns	
t_f	Fall Time			78		ns	
E_{on}	Turn-On Switching Loss				8.60		mJ
E_{off}	Turn-Off Switching Loss				33.1		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=900\text{V}, I_D=400\text{A}, R_G=1.6\Omega, V_{GS}=0/+18\text{V}, T_j=150^\circ\text{C}$		100		ns	
t_r	Rise Time			95		ns	
$t_{d(off)}$	Turn-Off Delay Time			343		ns	
t_f	Fall Time			82		ns	
E_{on}	Turn-On Switching Loss				8.65		mJ
E_{off}	Turn-Off Switching Loss				33.3		mJ

Inverse Diode Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_{SD}	Diode Forward Voltage	$I_S=240\text{A}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$		3.20		V
t_{rr}	Diode Reverse Recovery Time	$V_R=600\text{V}, I_S=240\text{A},$ $-di/dt=13200\text{A}/\mu\text{s},$ $T_j=25^\circ\text{C}$		25		ns
Q_r	Diode Reverse Recovery Charge			1.32		μC
I_{RM}	Peak Reverse Recovery Current			108		A

Series Diode Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=400\text{A}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$		1.40	1.85	V
		$I_F=400\text{A}, V_{GE}=0\text{V}, T_j=125^\circ\text{C}$		1.80		
		$I_F=400\text{A}, V_{GE}=0\text{V}, T_j=150^\circ\text{C}$		1.90		
t_{rr}	Diode Reverse Recovery Time	$V_R=900\text{V}, I_S=400\text{A},$ $-di/dt=4550\text{A}/\mu\text{s},$ $V_{GS}=0\text{V},$ $T_j=25^\circ\text{C}$		34.8		ns
Q_r	Diode Reverse Recovery Charge			2.75		μC
I_{rrm}	Peak Reverse Recovery Current			79		A
E_{rec}	Reverse Recovery Energy			0.23		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=900\text{V}, I_S=400\text{A},$ $-di/dt=4600\text{A}/\mu\text{s},$ $V_{GS}=0\text{V},$ $T_j=125^\circ\text{C}$		37.2		ns
Q_r	Diode Reverse Recovery Charge			3.05		μC
I_{rrm}	Peak Reverse Recovery Current			82		A
E_{rec}	Reverse Recovery Energy			0.51		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=900\text{V}, I_S=400\text{A},$ $-di/dt=4650\text{A}/\mu\text{s},$ $V_{GS}=0\text{V},$ $T_j=150^\circ\text{C}$		38.4		ns
Q_r	Diode Reverse Recovery Charge			3.19		μC
I_{rrm}	Peak Reverse Recovery Current			83		A
E_{rec}	Reverse Recovery Energy			0.53		mJ

Module Characteristics $T_c=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
R_{thJC}	Junction-to-Case(Mosfet)			0.074	K/W
	Junction-to-Case(Diode)			0.061	
R_{thCH}	Case-to-Heatsink (Mosfet)		0.022		K/W
	Case-to-Heatsink (Diode)		0.018		
	Case-to-Heatsink (per Module)		0.010		
M	Terminal Connection Torque, Screw M6	2.5		5.0	N.m
	Mounting Torque, Screw M6	3.0		5.0	
G	Weight of Module		300		g

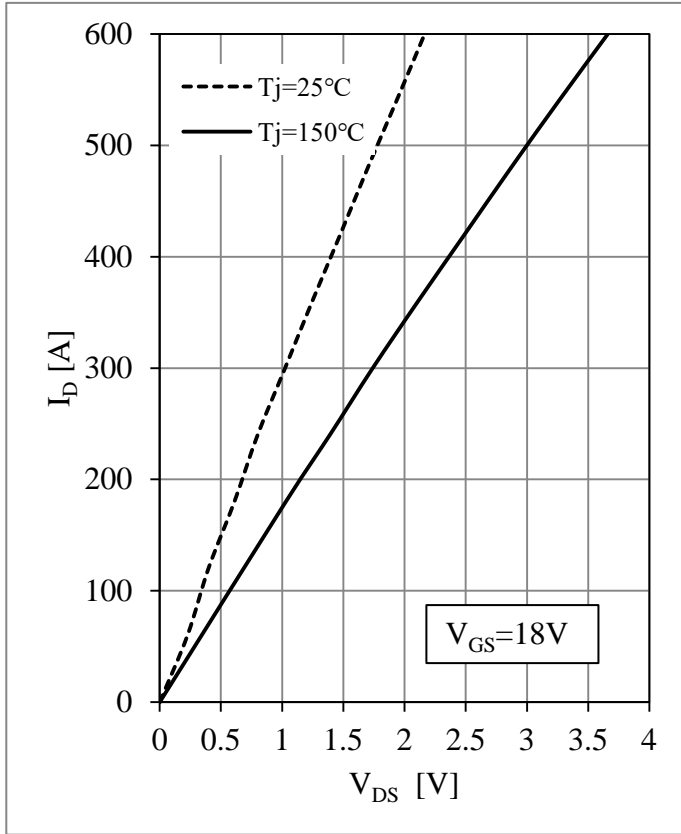


Fig 1. MOSFET Output Characteristics

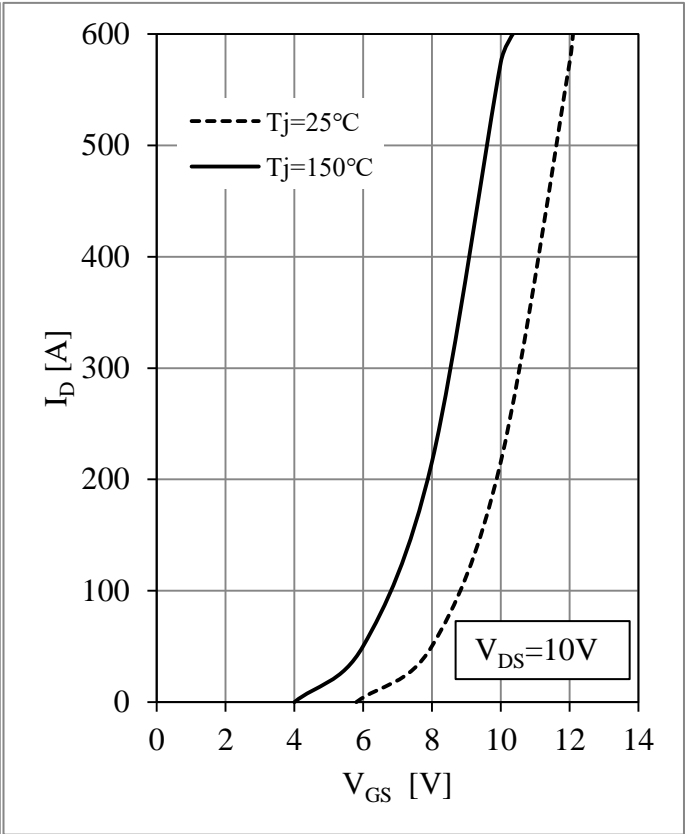


Fig 2. MOSFET Transfer Characteristics

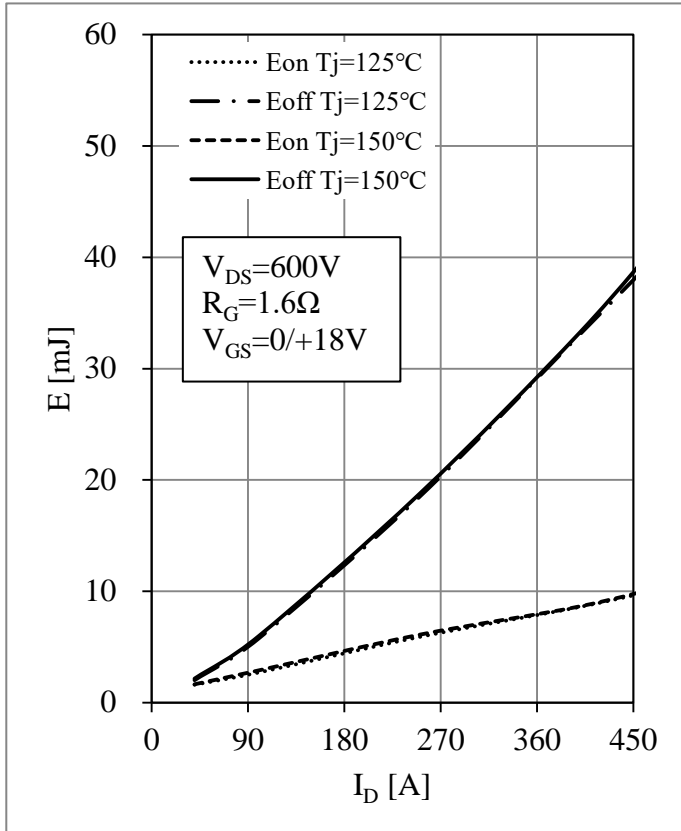


Fig 3. MOSFET Switching Loss vs. I_D

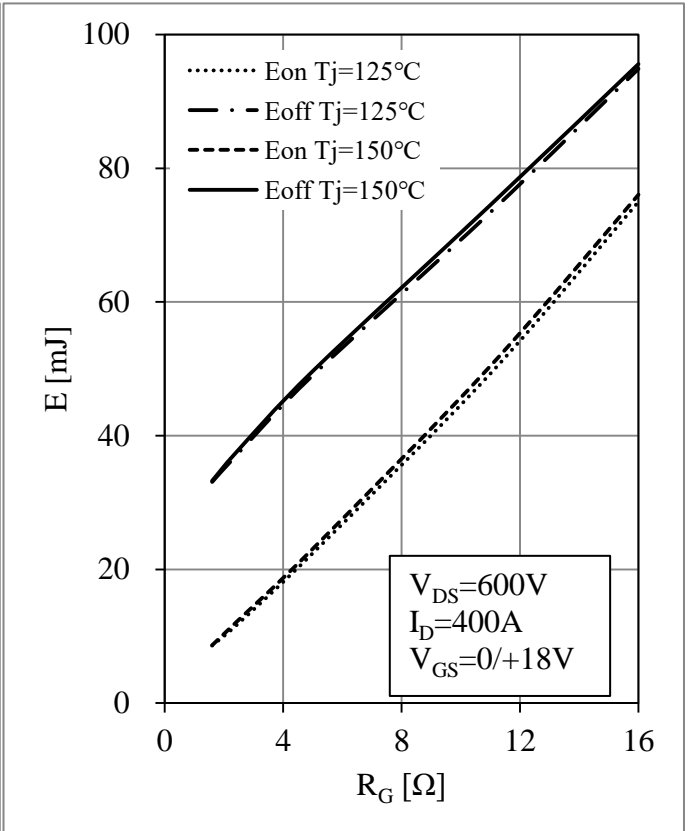


Fig 4. MOSFET Switching Loss vs. R_G

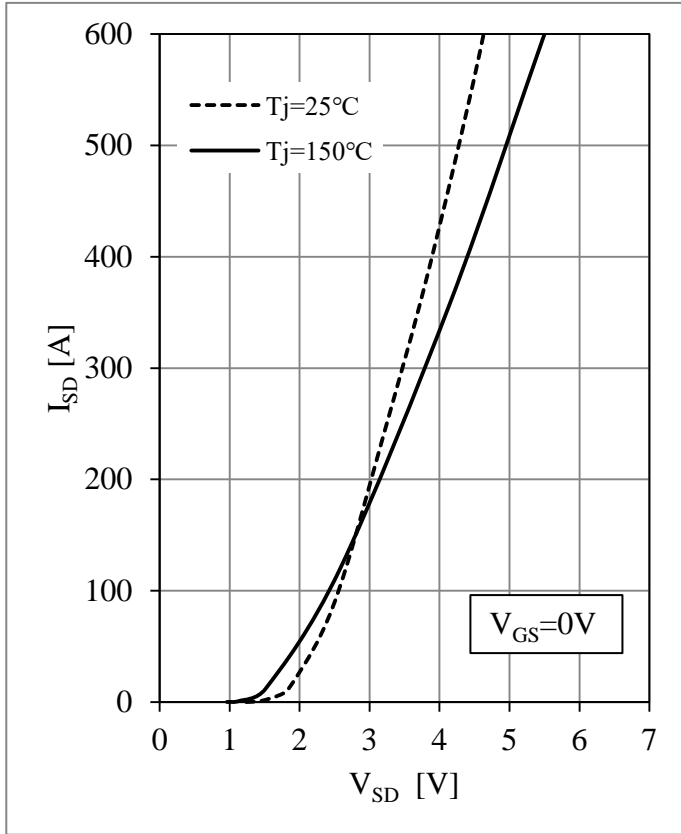


Fig 5. Body Diode Output Characteristics

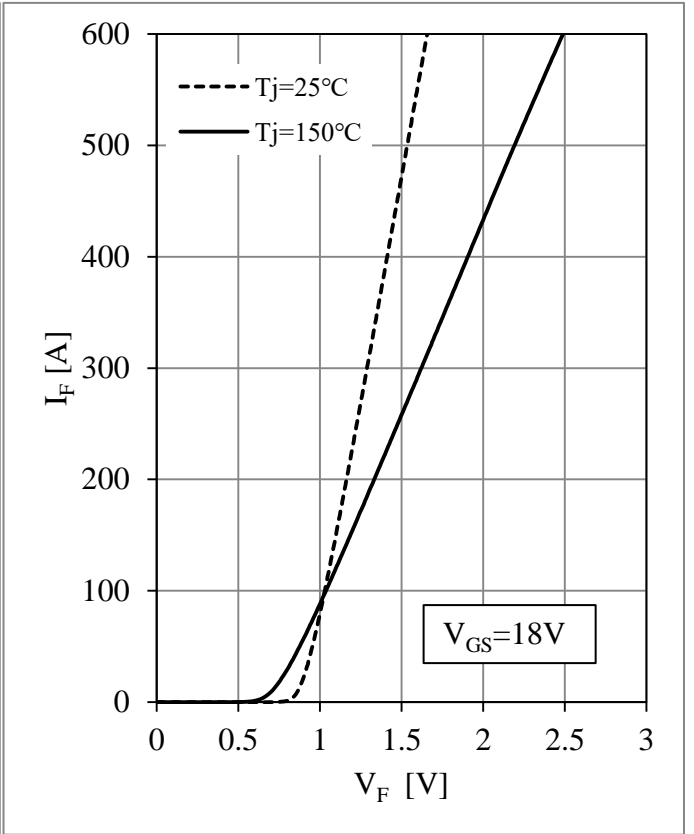


Fig 6. Diode Output Characteristics

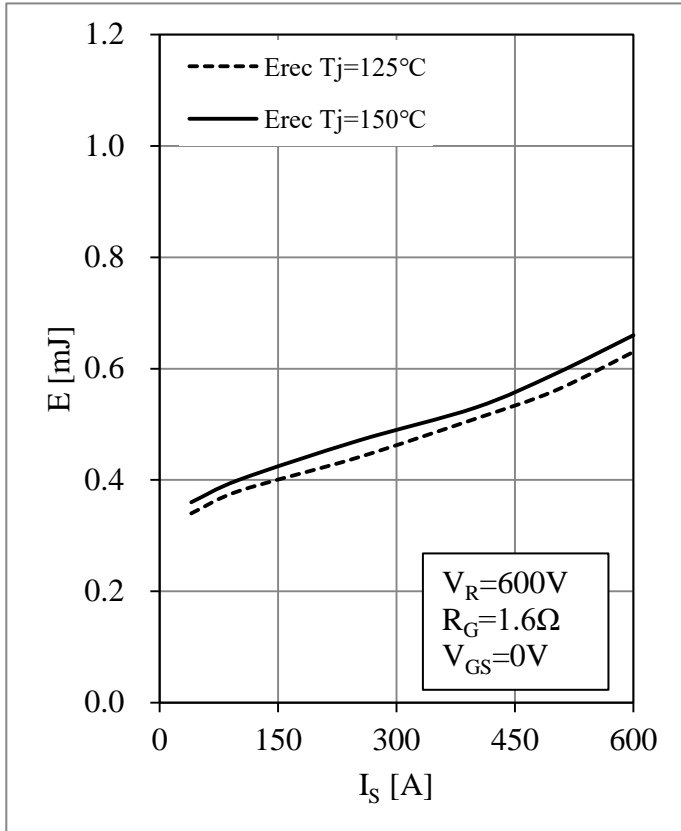


Fig 7. Diode Switching Loss vs. I_S

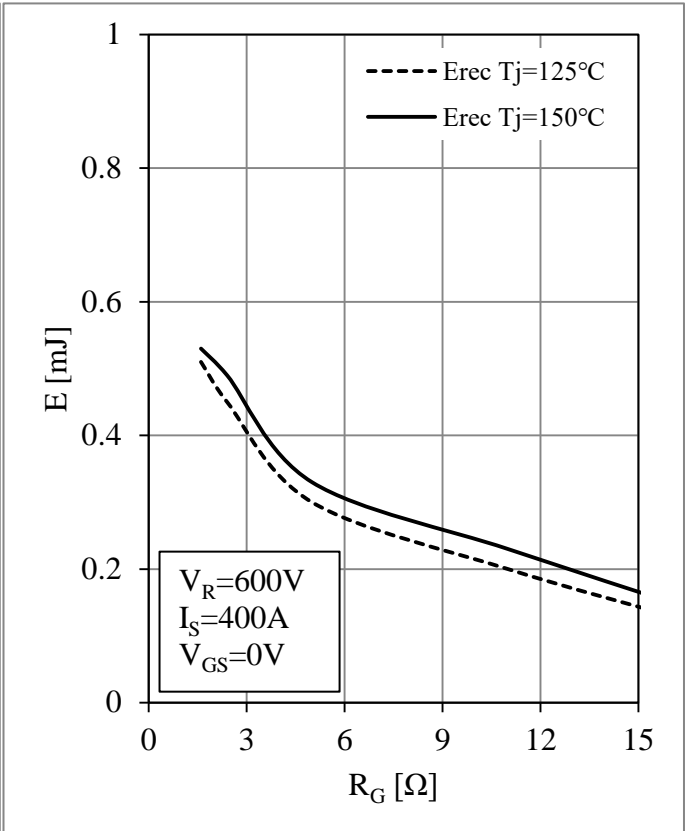


Fig 8. Diode Switching Loss vs. R_G

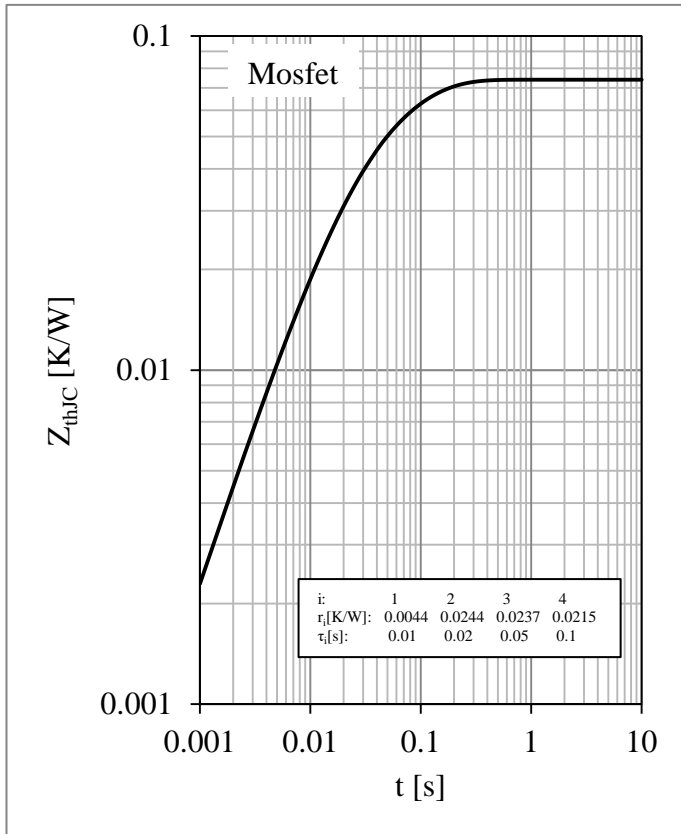
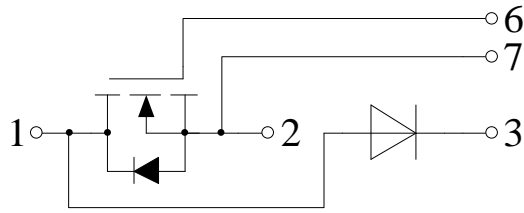


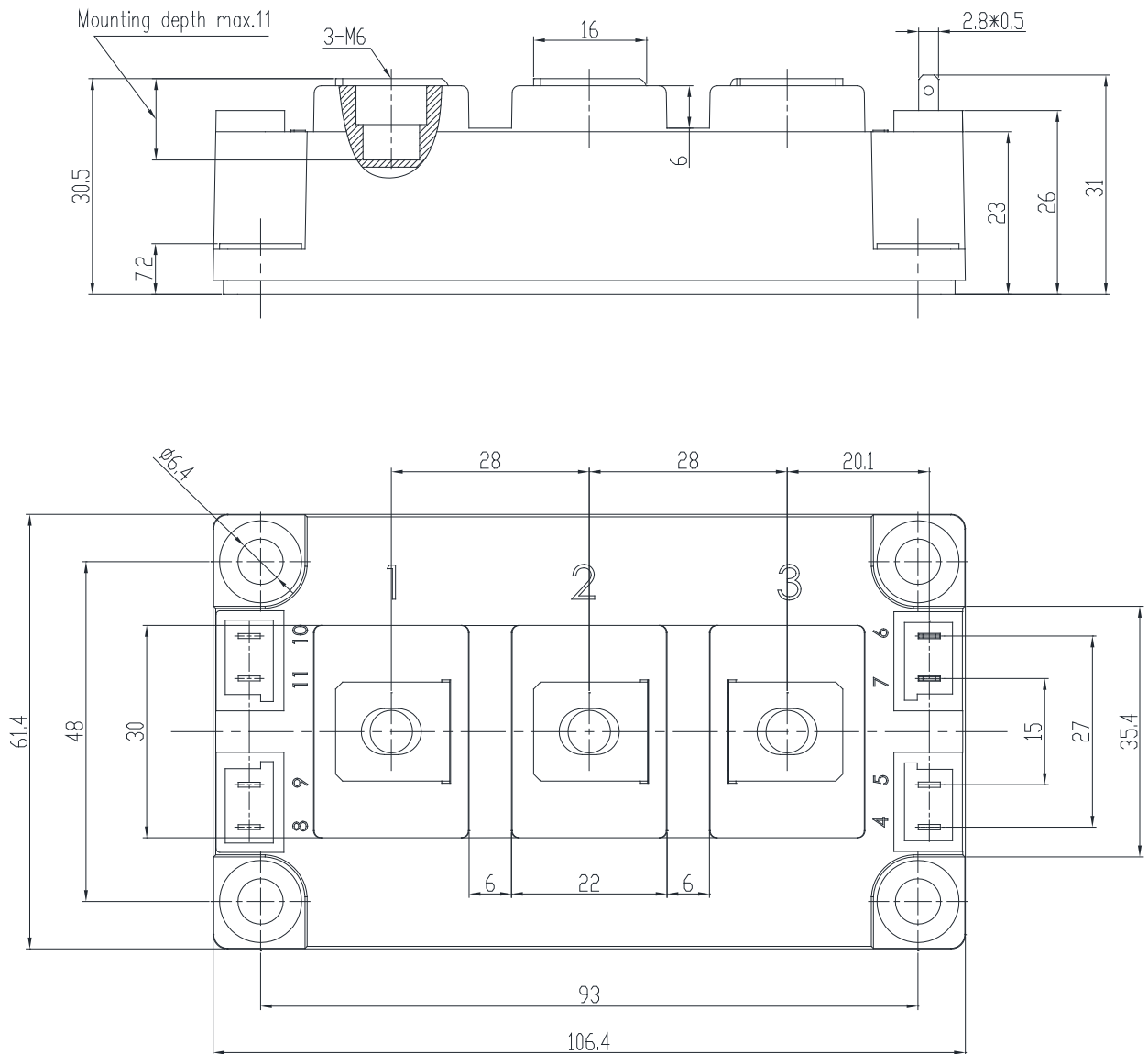
Fig 9. MOSFET Transient Thermal Impedance

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



Terms and Conditions of Usage

The data contained in this product datasheet is exclusively intended for technically trained staff. you and your technical departments will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to such application.

This product data sheet is describing the characteristics of this product for which a warranty is granted. Any such warranty is granted exclusively pursuant the terms and conditions of the supply agreement. There will be no guarantee of any kind for the product and its characteristics.

Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of our product, please contact the sales office, which is responsible for you (see www.powersemi.cc), For those that are specifically interested we may provide application notes.

Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact the sales office, which is responsible for you.

Should you intend to use the Product in aviation applications, in health or live endangering or life support applications, please notify.

If and to the extent necessary, please forward equivalent notices to your customers.
Changes of this product data sheet are reserved.